Notice of References Cited Application/Control No. 10/617,722 Examiner Ryan M. Stiglic Applicant(s)/Patent Under Reexamination LAI ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2003/0023804 A1	01-2003	Matsuda et al.	710/313
	В	US-6,549,958 B1	04-2003	Kuba, Hirokazu	710/14
	С	US-5,784,581	07-1998	Hannah, Eric C.	710/110
	D	US-6,732,218 B2	05-2004	Overtoom et al.	710/313
	Е	US-6,230,226 B1	05-2001	Hu et al.	710/305
	F	US-2003/0030412 A1	02-2003	Matsuda et al.	320/127
	G	US-6,820,166 B2	11-2004	Kitagawa, Masayuki	710/316
	н	US-2003/0104835 A1	06-2003	Douhet, Gerard	455/557
	1	US-		,	
	J	US-			
	κ	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z	JP 2000196986 A	07-2000	Japan	HISAYOSHI, HIROKAZU	H04N 05/765
	0					
	Ρ					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Dallas Semicunductors; "USB On-The-Go Basics"; Dallas Semicunductors; December 20, 2002; available online at http://pdfserv.maxim-ic.com/en/an/AN1822.pdf .
	٧	
	W	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.